

# Search Notes



Application/Control No.

10/532,509

Examiner

Henry K. Choe

Applicant(s)/Patent under Reexamination

CHEN ET AL.

Art Unit

2817

## SEARCHED

Class	Subclass	Date	Examiner
330	2	11/13/06	H.K.
"	41	"	"
"	42	11/14/06	"
"	43	"	"
"	44	"	"
"	136	"	"
"	149	11/15/06	"

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Searched done 11/15/06 H.K.			
see attachment			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Tral sub (Eent) see attachment	11/15/06	H.K.
NPL (IEEE) see attachment	"	"